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Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/605,227	CHENG ET AL.	
Examiner	Art Unit	
Kiesha L. Rose	2822	

SEARCHED			
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
Interference search		7/7/2006	KLR	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated search	7/7/2006	KLR	